Page 1 of 4 Applicant(s) Application No. PTO-1449 Uninown 10/650030 Daniel E. Evanicky, et al. Filing Date Group Art Unit Docket Number **Information Disclosure Citation** August 25, 2003 062986.0295 Unknown 2629 In an Application **U.S. PATENT DOCUMENTS SUBCLASS** FILING DATE **CLASS** DOCUMENT NO. DATE NAME 4,379,292 04/1983 Minato, et al. Α KMN 4,386,345 05/1983 Narveson, et al. В \overline{c} 4,912,558 03/1990 Easterly, et al. 10/1993 Kikuo, et al. $\overline{\mathbf{D}}$ 5,250,937 03/29/1994 Edgar, et al. Ē 5,298,993 F 05/1994 5,315,378 Satou, et al. 06/10/1997 Engeldrum, et al. G 5,638,117 5,428,720 06/1995 Adams, Jr. H Ī 5,502,458 03/1996 Braudaway, et al. 10/1997 J 5,680,180 Huang \overline{K} 5,731,794 03/1998 Miyazawa 5,739,809 04/1998 McLaughlin, et al. L 04/1999 Awamoto, et al. M 5,898,414 06/1999 Takemura N 5,920,358 0 5,926,239 07/1999 Kumar, et al. P 6,043,797 03/2000 Clifton, et al. FOREIGN PATENT DOCUMENTS TRANSLATION DOCUMENT NO. DATE **COUNTRY CLASS SUBCLASS** YES NO 96/01466 1/18/1996 PCT KMN 0539943 A1 05/05/1993 EP R S 0562971 A1 09/29/1993 EP 0597797 A1 05/18/1994 DOCUMENT (Including Author, Title, Source, and Pertinent Pages) DATE "White Balance Control Methods on Liquid Crystal Display", IBM Technical Disclosure Bulletin, MM Vol. 37, No. 11, Nov. 1, 1994, Page 425/426. DATE CONSIDERED /Kevin M. Nguyen/ 06/28/2006

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